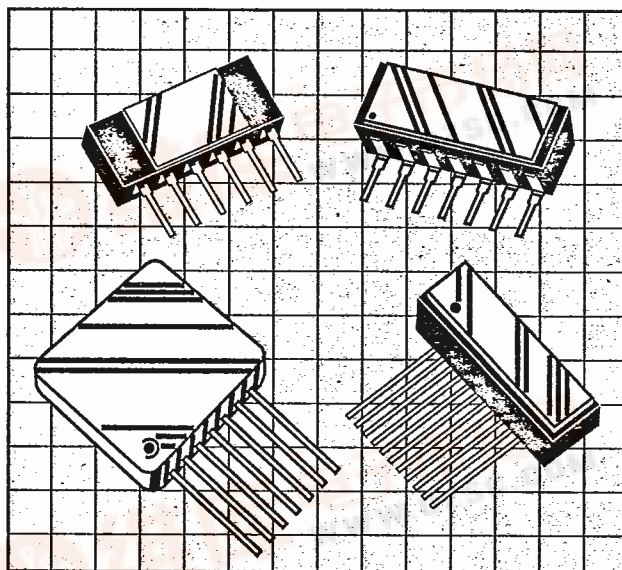


[查询"1462"供应商](#)

T-62-05

A COMPANY OF
VISHAY
VISHAY FOIL
RESISTORS

Precision Hermetic SIP Resistor Networks



Models 1461, 1462, 1463,
1464 and 1466

VISHAY Precision Hermetic Resistor Networks are now available in SIP (Single-In-Line Pin) configurations. Five models are available, using either Bulk Metal® Foil (1Ω to 30KΩ) chips or state-of-the-art thin film (30KΩ to 500KΩ) chips, and providing the high level performance of other VISHAY Bulk Metal® Foil and thin film products.

Ordering Information

Networks are custom designed and built. Therefore, a special part number is assigned which defines the package, circuit design, resistance values, tolerances, match, TCR, etc. Consult VISHAY Applications Engineering Department for assistance.

- **Resistance Range**
Thin Film: 30KΩ to 500KΩ
Bulk Metal® Foil: 1Ω to 30KΩ
- **Resistance Tolerance**
Thin Film: ±0.02% tightest; ±1% loosest
Bulk Metal® Foil: ±0.005% tightest; ±1% loosest
- **Temperature Coefficient of Resistance**
(-55°C to +125°C)
Thin Film: ±15 ppm/°C, Absolute
Bulk Metal® Foil: ±5 ppm/°C, Absolute
- **TCR Tracking**
Thin Film: to 3 ppm/°C
Bulk Metal® Foil: to 0.5 ppm/°C
- **Power Rating**
0.1 watt per chip @ +70°C
- **Load Life Stability** (1,000 hours @ +70°C)
Thin Film: ±0.1% ΔR maximum
Bulk Metal® Foil: ±0.015% ΔR maximum
- **Hermeticity**
< 5 x 10⁻⁷ cc/sec

T-62-05

TABLE 1 PACKAGE TYPES AND CHARACTERISTICS

VISHAY Model Number	Number of Leads	Chip Capacity ¹	Maximum Dimensions ²			Lead Length (Minimum)	Lead Spacing
			L	H	TH		
1461	6	3	0.586 x 0.300 x 0.100			0.150	0.100
1462	7	12	0.425 x 0.425 x 0.130			0.350	0.050
1463	7	10	0.785 x 0.360 x 0.130			0.125	0.100
1464	8	12	0.810 x 0.360 x 0.130			0.125	0.100
1466	11	5	0.900 x 0.250 x 0.130			0.400	0.050

NOTES

1. Chips used are V15x5 (150 x 50 mils). For values 10K Ω and below, V5x5 (50x50 mils) foil chips can be used providing more chip capacity. If both Bulk Metal[®] Foil and thin film chips are used in the network, the TC (temperature coefficient) tracking will be 10 ppm/ $^{\circ}$ C typical, 15 ppm/ $^{\circ}$ C maximum.

2. Height (H) dimension is top of the package to lead seating plane.

TABLE 2 VISHAY Miniature Thin Film & Bulk Metal[®] SIP Network Performance vs MIL-R-83401 Specs

Test or Condition	MIL-R-83401C					VISHAY Thin Film		VISHAY Bulk Metal [®] Foil	
	C	V	H	K	M	Typical	Maximum	Typical	Maximum
Resistance Temp Characteristic (ppm/ $^{\circ}$ C)	± 50	± 50	± 50	± 100	± 300	± 10	± 15	± 2 ppm/ $^{\circ}$ C	± 5 ppm/ $^{\circ}$ C
Tracking To Reference Element (-55 to +125 $^{\circ}$ C)	± 5 ppm/ $^{\circ}$ C	± 5 ppm/ $^{\circ}$ C	NA	NA	NA	± 3 ppm/ $^{\circ}$ C	± 5 ppm/ $^{\circ}$ C	± 2 ppm/ $^{\circ}$ C	± 5 ppm/ $^{\circ}$ C
Maximum Ambient Temp at Rated Wattage	+70 $^{\circ}$ C								
Maximum Ambient Temp at Zero Power	+125 $^{\circ}$ C								
Thermal Shock and Power Conditioning	ΔR Δ Ratio	$\pm 0.25\%$ $\pm 0.03\%$	$\pm 0.25\%$ $\pm 0.03\%$	$\pm 0.50\%$ NA	$\pm 0.70\%$ NA	$\pm 0.70\%$ NA	$\pm 0.01\%$ $\pm 0.01\%$	$\pm 0.02\%$ $\pm 0.02\%$	$\pm 0.003\%$ $\pm 0.003\%$
Low Temperature Operation	ΔR Δ Ratio	$\pm 0.10\%$ $\pm 0.02\%$	$\pm 0.10\%$ $\pm 0.02\%$	$\pm 0.10\%$ NA	$\pm 0.25\%$ NA	$\pm 0.50\%$ NA	$\pm 0.005\%$ $\pm 0.005\%$	$\pm 0.01\%$ $\pm 0.01\%$	$\pm 0.005\%$ $\pm 0.005\%$
Short Time Overload	ΔR Δ Ratio	$\pm 0.10\%$ $\pm 0.02\%$	$\pm 0.10\%$ $\pm 0.02\%$	$\pm 0.10\%$ NA	$\pm 0.25\%$ NA	$\pm 0.50\%$ NA	$\pm 0.005\%$ $\pm 0.005\%$	$\pm 0.01\%$ $\pm 0.01\%$	$\pm 0.002\%$ $\pm 0.002\%$
Terminal Strength	ΔR Δ Ratio	$\pm 0.10\%$ $\pm 0.03\%$	$\pm 0.10\%$ $\pm 0.03\%$	$\pm 0.25\%$ NA	$\pm 0.25\%$ NA	$\pm 0.25\%$ NA	$\pm 0.002\%$ $\pm 0.002\%$	$\pm 0.01\%$ $\pm 0.01\%$	$\pm 0.001\%$ $\pm 0.001\%$
Resistance to Soldering Heat	ΔR Δ Ratio	$\pm 0.10\%$ $\pm 0.02\%$	$\pm 0.10\%$ $\pm 0.02\%$	$\pm 0.10\%$ NA	$\pm 0.25\%$ NA	$\pm 0.25\%$ NA	$\pm 0.005\%$ $\pm 0.005\%$	$\pm 0.01\%$ $\pm 0.01\%$	$\pm 0.002\%$ $\pm 0.001\%$
Moisture Resistance	ΔR Δ Ratio	$\pm 0.20\%$ $\pm 0.02\%$	$\pm 0.20\%$ $\pm 0.02\%$	$\pm 0.40\%$ NA	$\pm 0.50\%$ NA	$\pm 0.50\%$ NA	$\pm 0.003\%$ $\pm 0.003\%$	$\pm 0.01\%$ $\pm 0.01\%$	$\pm 0.003\%$ $\pm 0.003\%$
Shock (Specified Pulse)	ΔR Δ Ratio	$\pm 0.25\%$ $\pm 0.03\%$	$\pm 0.25\%$ $\pm 0.03\%$	$\pm 0.25\%$ NA	$\pm 0.25\%$ NA	$\pm 0.25\%$ NA	$\pm 0.002\%$ $\pm 0.002\%$	$\pm 0.01\%$ $\pm 0.01\%$	$\pm 0.001\%$ $\pm 0.001\%$
Vibration, High Frequency	ΔR Δ Ratio	$\pm 0.25\%$ $\pm 0.03\%$	$\pm 0.25\%$ $\pm 0.03\%$	$\pm 0.25\%$ NA	$\pm 0.25\%$ NA	$\pm 0.25\%$ NA	$\pm 0.002\%$ $\pm 0.002\%$	$\pm 0.01\%$ $\pm 0.01\%$	$\pm 0.001\%$ $\pm 0.001\%$
Load Life (+70 $^{\circ}$ C, Full Power, 1,000 Hours)	ΔR Δ Ratio	$\pm 0.10\%$ $\pm 0.03\%$	$\pm 0.10\%$ $\pm 0.03\%$	$\pm 0.50\%$ NA	$\pm 0.50\%$ NA	$\pm 2.00\%$ NA	$\pm 0.05\%$ $\pm 0.01\%$	$\pm 0.1\%$ $\pm 0.025\%$	$\pm 0.015\%$ $\pm 0.005\%$
+25 $^{\circ}$ C Power Rating (1,000 Hours)	ΔR Δ Ratio	$\pm 0.10\%$ $\pm 0.03\%$	$\pm 0.10\%$ $\pm 0.03\%$	$\pm 0.50\%$ NA	$\pm 0.50\%$ NA	$\pm 2.00\%$ NA	$\pm 0.02\%$ $\pm 0.005\%$	$\pm 0.05\%$ $\pm 0.01\%$	$\pm 0.002\%$ $\pm 0.001\%$
High Temperature Exposure (+125 $^{\circ}$ C, 100 Hours)	ΔR Δ Ratio	$\pm 0.10\%$ $\pm 0.03\%$	$\pm 0.10\%$ $\pm 0.03\%$	$\pm 0.20\%$ NA	$\pm 0.50\%$ NA	$\pm 1.00\%$ NA	$\pm 0.03\%$ $\pm 0.01\%$	$\pm 0.05\%$ $\pm 0.02\%$	$\pm 0.005\%$ $\pm 0.005\%$
Low Temperature Storage	ΔR Δ Ratio	$\pm 0.10\%$ $\pm 0.02\%$	$\pm 0.10\%$ $\pm 0.02\%$	$\pm 0.10\%$ NA	$\pm 0.25\%$ NA	$\pm 0.50\%$ NA	$\pm 0.01\%$ $\pm 0.01\%$	$\pm 0.02\%$ $\pm 0.02\%$	$\pm 0.002\%$ $\pm 0.002\%$
Insulation Resistance	10,000M Ω								
Resistance Tolerance and, when applicable, Resistance Ratio Accuracy	$\pm 0.1\%$ (B) $\pm 0.5\%$ (D) $\pm 1.0\%$ (F)	$\pm 0.1\%$ (B) $\pm 0.5\%$ (D) $\pm 1.0\%$ (F)	$\pm 0.1\%$ (B) $\pm 0.5\%$ (D) $\pm 1.0\%$ (F)	$\pm 0.5\%$ (D) $\pm 1.0\%$ (F) $\pm 2.0\%$ (G)	$\pm 1.0\%$ (F) $\pm 2.0\%$ (G) $\pm 5.0\%$ (J)	$\pm 0.02\%$ $\pm 0.05\%$ (A)	$\pm 0.1\%$ (B) $\pm 0.5\%$ (D) $\pm 1.0\%$ (F)	$\pm 0.005\%$ (V) $\pm 0.01\%$ (T) $\pm 0.05\%$ (A)	$\pm 0.1\%$ (B) $\pm 0.5\%$ (D) $\pm 1.0\%$ (F)

NOTES

1. ΔR 's are not cumulative. For purposes of determining reliability calculations, consider the characteristics shown as figures of merit and allow no more than $\pm 0.05\%$ ΔR lifetime. Allow proportionately less if the severity of anticipated environmental stress is small compared to the tests as defined in MIL-R-83401.

2. Post Manufacturing Operation (PMO)—screening—has the effect of minimizing ΔR 's. Consult VISHAY Applications Engineering Department for details.

3. Δ Ratio refers to the change in ratio between resistors within the network package from before, to after, the specified test.